Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/667,511	MIYAMORI ET AL.
Examiner	Art Unit
Binh X. Tran	1765

	SEARCHED				
Class	Subclass	Date	Examiner		
438	697	9/13/2005	вт		
438	703	9/13/2005	ВТ		
438	722	9/13/2005	вт		

INT	INTERFERENCE SEARCHED				
Class	Subclass	Dațe.	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Search keywords and inventor's name using USPAT, USPG-PUB, JPO, EPO, DERWENT databases	9/13/2005	вт		
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